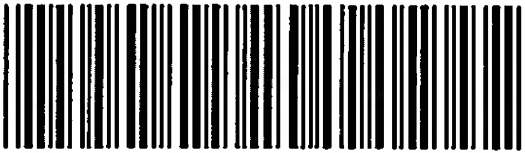


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/015,921	BAILIS ET AL.	
	Examiner	Art Unit	
	Paul Dinh	2825	

SEARCHED			
Class	Subclass	Date	Examiner
716	1	2/7/2005	PD
716	4-5	2/7/2005	PD
716	16-18	2/7/2005	PD

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST, IEEE	2/7/2005	PD